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SEMICONDUCTOR IM

### **FDN302P**

#### P-Channel 2.5V Specified PowerTrench<sup>®</sup> MOSFET

#### **General Description**

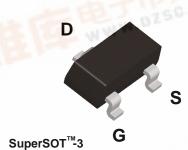
This P-Channel 2.5V specified MOSFET uses a rugged gate version of Fairchild's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V).

#### Applications

- · Power management
- Load switch
- Battery protection

#### Features

- -20 V, -2.4 A.  $R_{DS(ON)} = 0.055 \ \Omega @ V_{GS} = -4.5 \ V$  $R_{DS(ON)} = 0.080 \ \Omega \ @ V_{GS} = -2.5 \ V$
- · Fast switching speed
- High performance trench technology for extremely low R<sub>DS(ON)</sub>
- SuperSOT<sup>™</sup> -3 provides low R<sub>DS(ON)</sub> and 30% higher power handling capability than SOT23 in the same footprint



### D S G

#### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	V
ID	Drain Current – Continuous	(Note 1a)	-2.4	A
	– Pulsed		-10	TO Y
P <sub>D</sub>	Maximum Power Dissipation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	I Characteristics_			
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
Raic	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

#### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
302	FDN302P	7"	8mm	3000 units



## FDN302P

October 2000

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			1		
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		-12		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 V$ , $V_{GS} = 0 V$			-1	μA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate–Body Leakage, Reverse	$V_{GS} = -12 \text{ V} \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.6	-1.0	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu A$ , Referenced to $25^{\circ}C$		3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{GS} = -4.5 \ V,  I_D = -2.4 \ A \\ V_{GS} = -2.5 \ V,  I_D = -2 \ A \\ V_{GS} = -4.5 \ V, \ I_D = -2.4 \ A, \ T_J = 125^\circ C \end{array} $		44 64 58	55 80 84	mΩ
I <sub>D(on)</sub>	On–State Drain Current	$V_{GS} = -4.5 \text{ V},  V_{DS} = -5 \text{ V}$	-10			А
<b>g</b> fs	Forward Transconductance	$V_{DS} = -5 V$ , $I_D = -2.4 A$		10		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V},  V_{GS} = 0 \text{ V},$		882		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		211		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			112		pF
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -10 V$ , $I_D = -1 A$ ,		13	23	ns
tr	Turn–On Rise Time	$V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \ \Omega$		11	20	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			25	40	ns
t <sub>f</sub>	Turn–Off Fall Time			15	27	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_D = -2.4 \text{ A},$		9	14	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5 V$		2		nC
Q <sub>gd</sub>	Gate–Drain Charge			3		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Source				-0.42	А
V <sub>SD</sub>	Drain–Source Diode Forward	$V_{GS} = 0 V$ , $I_{S} = -0.42$ (Note 2)	1	-0.7	-1.2	V

Notes:

 R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.

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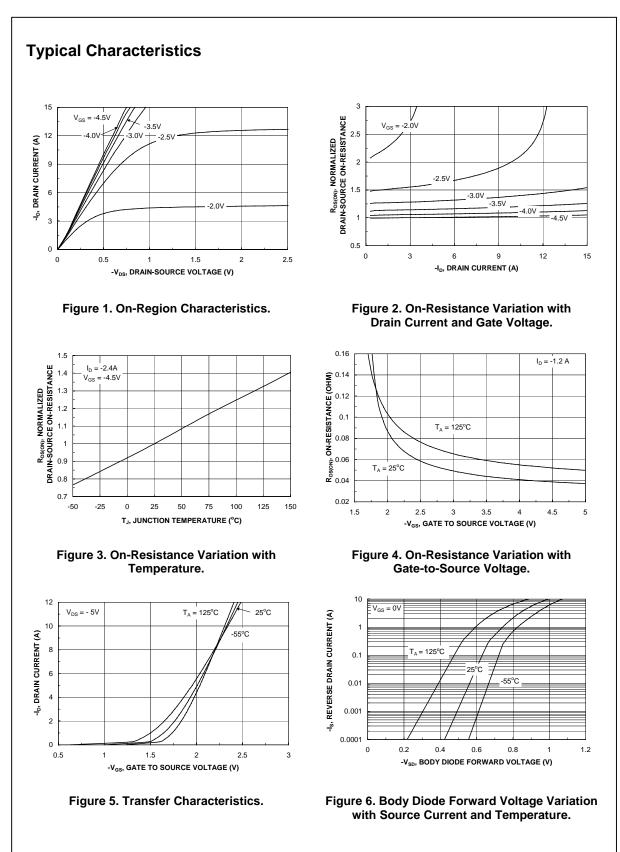


 a) 250°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz. copper. b) 270°C/W when mounted on a minimum pad.

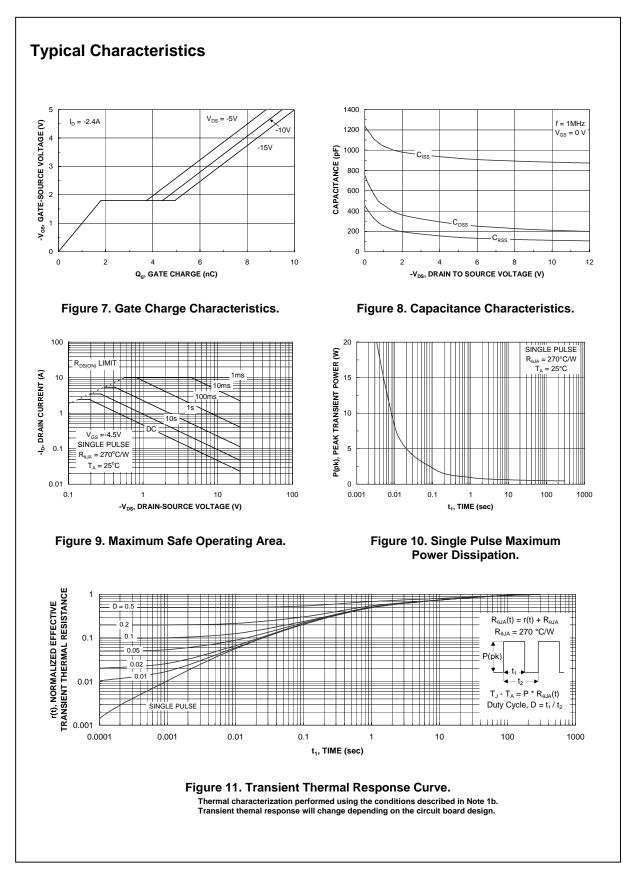
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq 300~\mu s,~\text{Duty}~\text{Cycle} \leq 2.0\%$ 

FDN302P



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#### PRODUCT STATUS DEFINITIONS

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
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